Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/662,280	FUJII ET AL.	
Examiner	Art Unit	
Steven H. VerSteed	1753	

	SEAR	CHED	
Class	Subclass	Date	Examiner
204	298.12, 298.41	5/17/2005	SHV
above	to date	9/12/2005	SHV
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
204	298.12	9/12/2005	SHV		
204	298.41	9/12/2005	SHV		

SEARCH (INCLUDING SEAF		)
	DATE	EXMR
Inventor name search	5/17/2005	SHV
EAST Search	5/17/2005	SHV
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